Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,216	SCHANTZ, JOHN L.	
Examiner	Art Unit	

2614

Benny Q. Tieu

SEARCHED					
Class	Subclass	Date	Examiner		
379	229 230 221.08- 221.1	10/28/2006	BQT		
370	401 410 467				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
See Interfer	ext Search, ence Search ntout	4/15/2007	BQT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	10/28/2006	BQT	
Interference Search History Printout	4/15/2007	BQT	